

60 A, 600 V, ultrafast IGBT

## Features

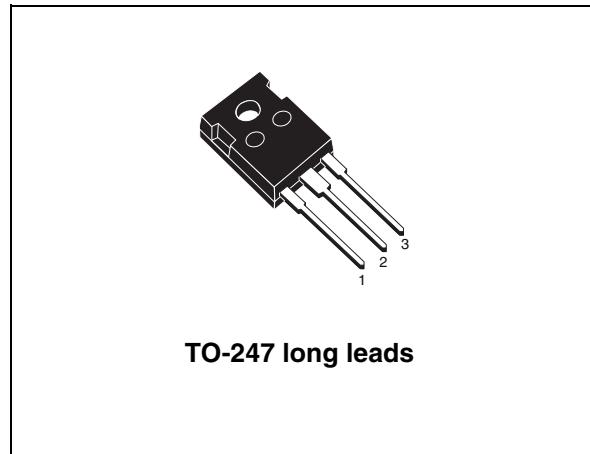
- Very high frequency operation
- Low  $C_{RES}$  /  $C_{IES}$  ratio (no cross-conduction susceptibility)
- Very soft ultrafast recovery antiparallel diode

## Applications

- Welding
- Power factor correction
- SMPS
- High frequency inverter/converter

## Description

This device is an ultrafast IGBT. It utilizes the advanced Power MESHTM process resulting in an excellent trade-off between switching performance and low on-state behavior.



TO-247 long leads

Figure 1. Internal schematic diagram

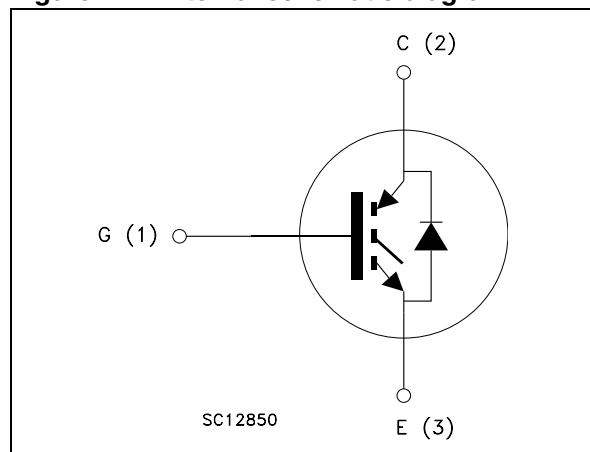


Table 1. Device summary

Order code	Marking	Package	Packaging
STGWA60NC60WDR	GWA60NC60WDR	TO-247 long leads	Tube

# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{CES}$	Collector-emitter voltage ( $V_{GE} = 0$ )	600	V
$I_C^{(1)}$	Collector current (continuous) at $T_C = 25^\circ\text{C}$	130	A
$I_C^{(1)}$	Collector current (continuous) at $T_C = 100^\circ\text{C}$	60	A
$I_{CL}^{(2)}$	Turn-off latching current	250	A
$I_{CP}^{(3)}$	Pulsed collector current	250	A
$I_F$	Diode RMS forward current at $T_C = 25^\circ\text{C}$	30	A
$I_{FSM}$	Surge not repetitive forward current ( $t_p = 10 \text{ ms}$ sinusoidal)	120	A
$V_{GE}$	Gate-emitter voltage	$\pm 20$	V
$P_{TOT}$	Total dissipation at $T_C = 25^\circ\text{C}$	340	W
$T_j$	Operating junction temperature	- 55 to 150	$^\circ\text{C}$

1. Calculated according to the iterative formula:

$$I_C(T_C) = \frac{T_{JMAX} - T_C}{R_{THJ-C} \times V_{CESAT(MAX)}(T_C, I_C)}$$

2.  $V_{clamp} = 480 \text{ V}$ ,  $T_J = 150^\circ\text{C}$ ,  $R_G = 10 \Omega$ ,  $V_{GE} = 15 \text{ V}$

3. Pulse width limited by max. temperature allowed

**Table 3. Thermal resistance**

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case IGBT max.	0.35	$^\circ\text{C/W}$
$R_{thj-case}$	Thermal resistance junction-case diode max.	1.25	$^\circ\text{C/W}$
$R_{thj-amb}$	Thermal resistance junction-ambient max.	50	$^\circ\text{C/W}$

## 2 Electrical characteristics

$T_{CASE} = 25^\circ\text{C}$  unless otherwise specified

**Table 4. Static**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)CES}$	Collector-emitter breakdown voltage ( $V_{GE} = 0$ )	$I_C = 1 \text{ mA}$	600			V
$V_{CE(\text{sat})}$	Collector-emitter saturation voltage	$V_{GE} = 15 \text{ V}, I_C = 40 \text{ A}$ $V_{GE} = 15 \text{ V}, I_C = 40 \text{ A}, T_C = 125^\circ\text{C}$		2.1 1.9	2.6	V V
$V_{GE(\text{th})}$	Gate threshold voltage	$V_{CE} = V_{GE}, I_C = 250 \mu\text{A}$	3.75		5.75	V
$I_{CES}$	Collector cut-off current ( $V_{GE} = 0$ )	$V_{CE} = 600 \text{ V}$ $V_{CE} = 600 \text{ V}, T_C = 125^\circ\text{C}$			500 5	$\mu\text{A}$ mA
$I_{GES}$	Gate-emitter leakage current ( $V_{CE} = 0$ )	$V_{GE} = \pm 20 \text{ V}$			$\pm 100$	nA
$g_{fs}$	Forward transconductance	$V_{CE} = 15 \text{ V}, I_C = 40 \text{ A}$		25		S

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{ies}$	Input capacitance			4700		pF
$C_{oes}$	Output capacitance	$V_{CE} = 25 \text{ V}, f = 1 \text{ MHz},$ $V_{GE} = 0$		410		pF
$C_{res}$	Reverse transfer capacitance			90		pF
$Q_g$	Total gate charge			195		nC
$Q_{ge}$	Gate-emitter charge	$V_{CE} = 390 \text{ V}, I_C = 40 \text{ A},$ $V_{GE} = 15 \text{ V},$ <i>Figure 16</i>		32		nC
$Q_{gc}$	Gate-collector charge			82		nC

**Table 6. Switching on/off (inductive load)**

<b>Symbol</b>	<b>Parameter</b>	<b>Test conditions</b>	<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	<b>Unit</b>
$t_{d(on)}$ $t_r$ $(di/dt)_{on}$	Turn-on delay time Current rise time Turn-on current slope	$V_{CC} = 390 \text{ V}$ , $I_C = 40 \text{ A}$ $R_G = 10 \Omega$ , $V_{GE} = 15 \text{ V}$ , <a href="#">Figure 17</a> , <a href="#">Figure 15</a>		40 30 1039		ns ns A/ $\mu\text{s}$
$t_{d(on)}$ $t_r$ $(di/dt)_{on}$	Turn-on delay time Current rise time Turn-on current slope	$V_{CC} = 390 \text{ V}$ , $I_C = 40 \text{ A}$ $R_G = 10 \Omega$ , $V_{GE} = 15 \text{ V}$ , $T_C = 125^\circ\text{C}$ <a href="#">Figure 17</a> , <a href="#">Figure 15</a>		37 32 990		ns ns A/ $\mu\text{s}$
$t_{r(Voff)}$ $t_{d(Voff)}$ $t_f$	Off voltage rise time Turn-off delay time Current fall time	$V_{CC} = 390 \text{ V}$ , $I_C = 40 \text{ A}$ $R_G = 10 \Omega$ , $V_{GE} = 15 \text{ V}$ , <a href="#">Figure 17</a> , <a href="#">Figure 15</a>		31 240 35		ns ns ns
$t_{r(Voff)}$ $t_{d(Voff)}$ $t_f$	Off voltage rise time Turn-off delay time Current fall time	$V_{CC} = 390 \text{ V}$ , $I_C = 40 \text{ A}$ $R_G = 10 \Omega$ , $V_{GE} = 15 \text{ V}$ , $T_C = 125^\circ\text{C}$ <a href="#">Figure 17</a> , <a href="#">Figure 15</a>		59 280 63		ns ns ns

**Table 7. Switching energy (inductive load)**

<b>Symbol</b>	<b>Parameter</b>	<b>Test conditions</b>	<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	<b>Unit</b>
$E_{on}^{(1)}$ $E_{off}^{(2)}$ $E_{ts}$	Turn-on switching losses Turn-off switching losses Total switching losses	$V_{CC} = 390 \text{ V}$ , $I_C = 40 \text{ A}$ $R_G = 10 \Omega$ , $V_{GE} = 15 \text{ V}$ , <a href="#">Figure 15</a>		743 560 925		$\mu\text{J}$ $\mu\text{J}$ $\mu\text{J}$
$E_{on}^{(1)}$ $E_{off}^{(2)}$ $E_{ts}$	Turn-on switching losses Turn-off switching losses Total switching losses	$V_{CC} = 390 \text{ V}$ , $I_C = 40 \text{ A}$ $R_G = 10 \Omega$ , $V_{GE} = 15 \text{ V}$ , $T_C = 125^\circ\text{C}$ <a href="#">Figure 15</a>		917 910 1545		$\mu\text{J}$ $\mu\text{J}$ $\mu\text{J}$

1. Eon is the tun-on losses when a typical diode is used in the test circuit in [Figure 18](#). If the IGBT is offered in a package with a co-pak diode, the co-pak diode is used as external diode. IGBTs & Diode are at the same temperature ( $25^\circ\text{C}$  and  $125^\circ\text{C}$ )
2. Turn-off losses include also the tail of the collector current

**Table 8. Collector-emitter diode**

<b>Symbol</b>	<b>Parameter</b>	<b>Test conditions</b>	<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	<b>Unit</b>
$V_F$	Forward on-voltage	$I_F = 40 \text{ A}$ $I_F = 40 \text{ A}$ , $T_C = 125^\circ\text{C}$		3.2 2.2		V V
$t_{rr}$ $Q_{rr}$ $I_{rrm}$	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_F = 40 \text{ A}$ , $V_R = 50 \text{ V}$ , $di/dt = 100 \text{ A}/\mu\text{s}$ <a href="#">Figure 18</a>		42 55 2.6		ns nC A
$t_{rr}$ $Q_{rr}$ $I_{rrm}$	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_F = 40 \text{ A}$ , $V_R = 50 \text{ V}$ , $T_C = 125^\circ\text{C}$ , $di/dt = 100 \text{ A}/\mu\text{s}$ ( <a href="#">Figure 18</a> )		141 324 4.6		ns nC A

## 2.1 Electrical characteristics (curves)

Figure 2. Output characteristics

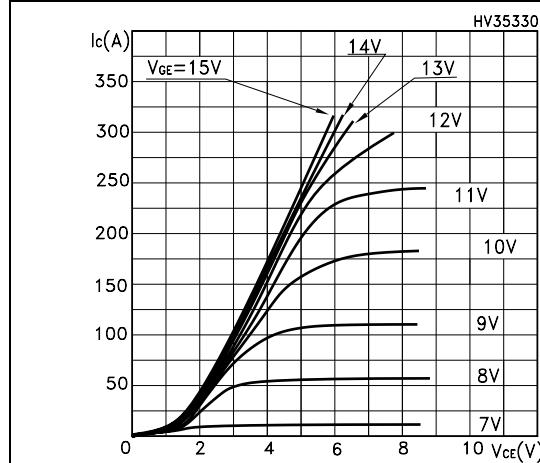


Figure 3. Transfer characteristics

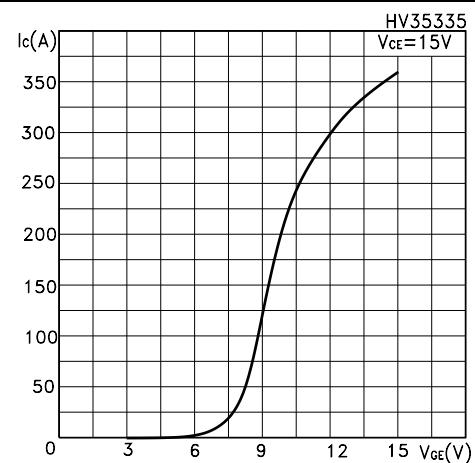


Figure 4. Transconductance

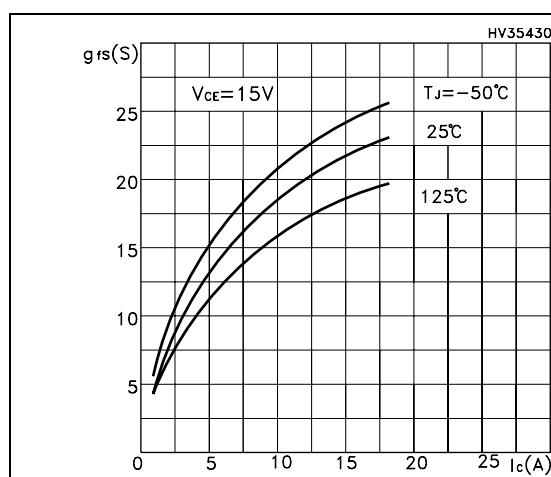


Figure 5. Collector-emitter on voltage vs. temperature

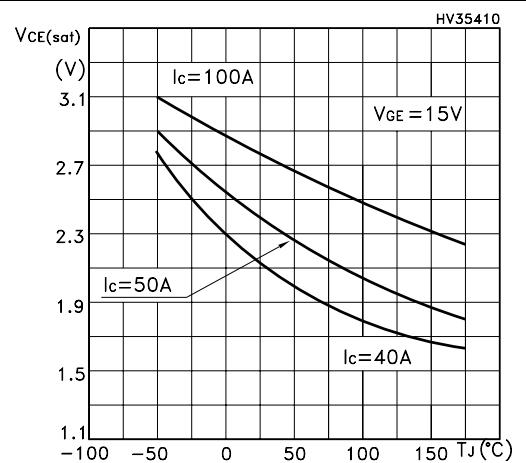


Figure 6. Gate charge vs. gate-source voltage

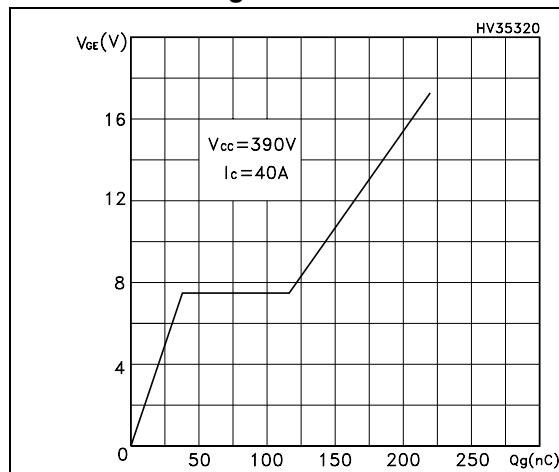
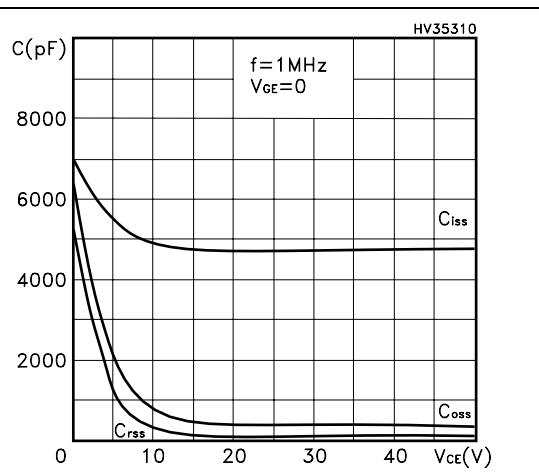
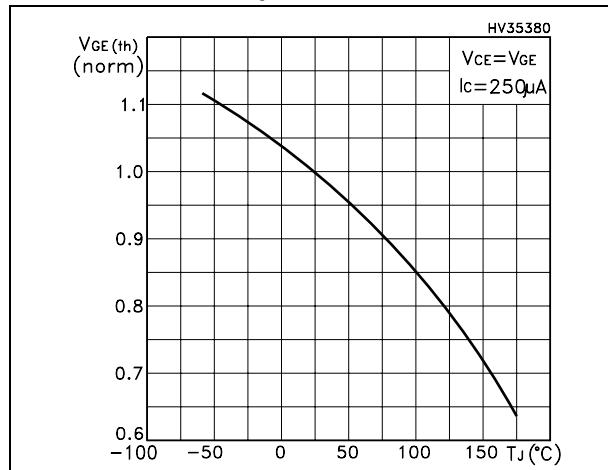
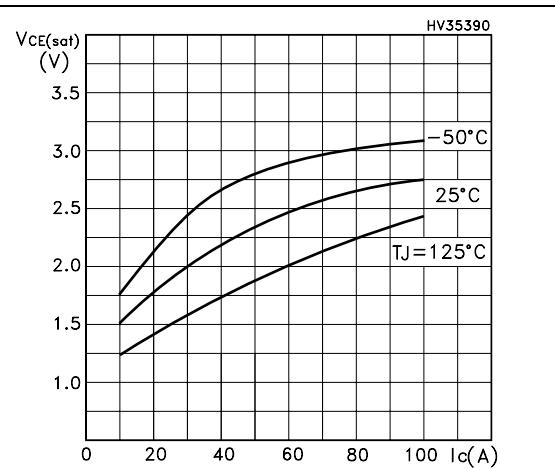
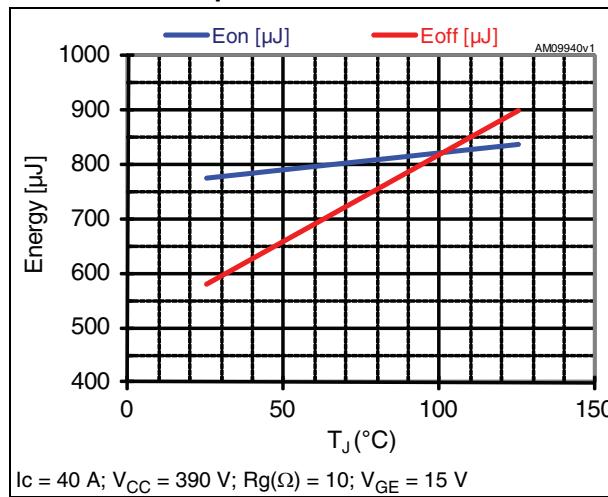
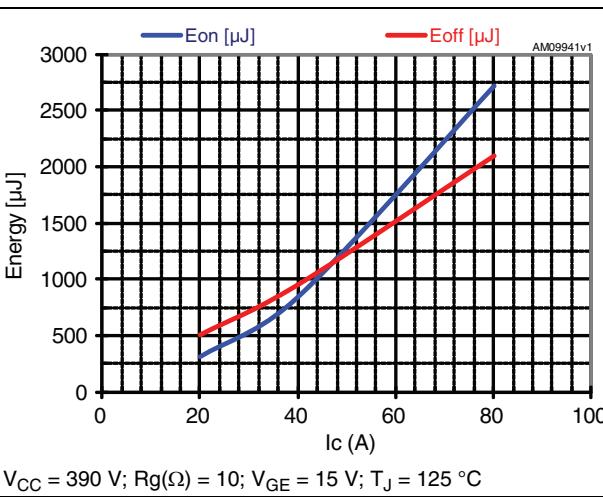
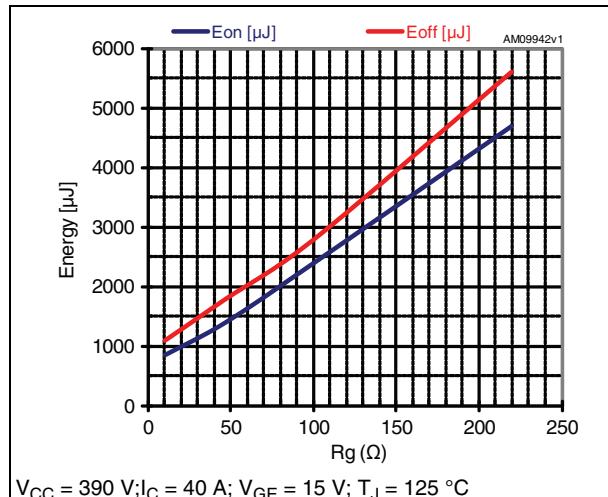
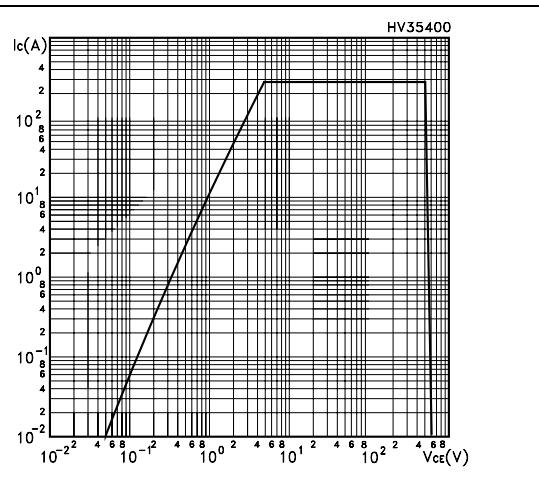
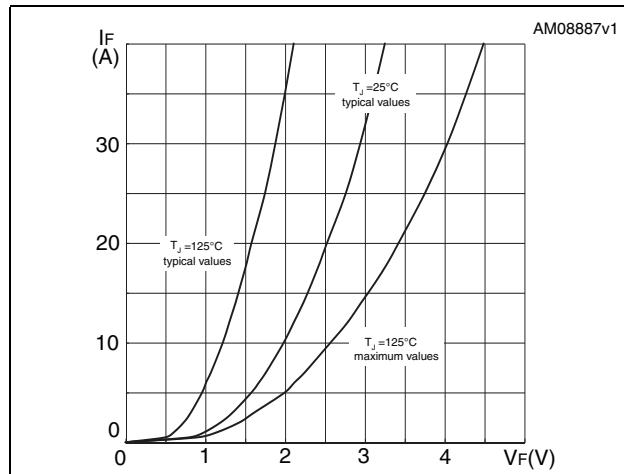


Figure 7. Capacitance variations



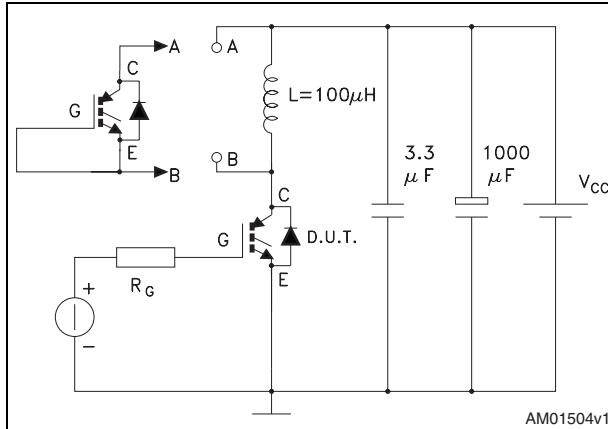
**Figure 8. Normalized gate threshold voltage vs. temperature****Figure 9. Collector-emitter on voltage vs. collector current****Figure 10. Normalized breakdown voltage vs. temperature****Figure 11. Switching losses vs. IC****Figure 12. Switching losses vs. gate resistance****Figure 13. Turn-off SOA**

**Figure 14. Forward voltage drop vs. forward current**

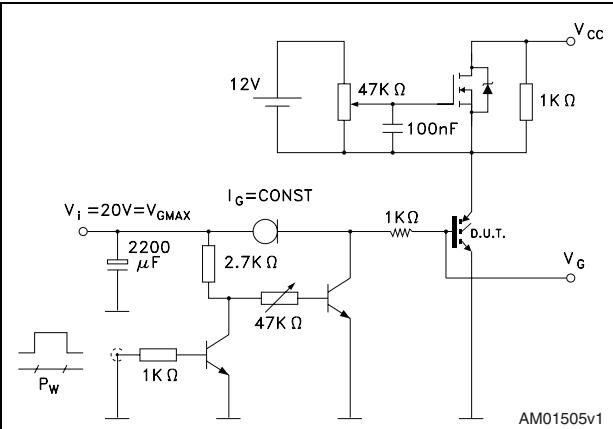


### 3 Test circuit

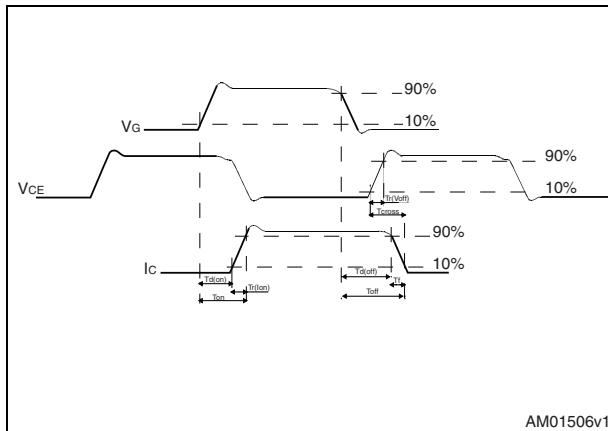
**Figure 15. Test circuit for inductive load switching**



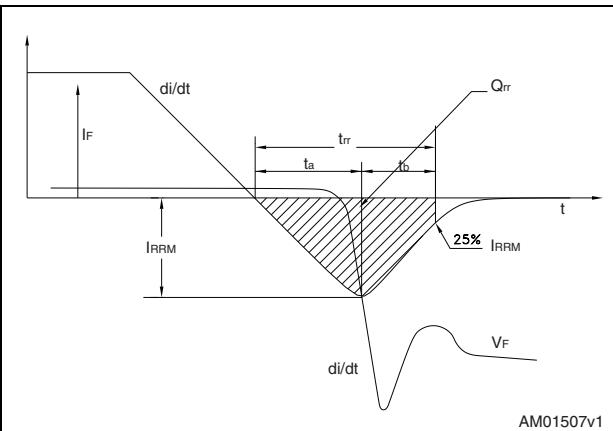
**Figure 16. Gate charge test circuit**



**Figure 17. Switching waveform**



**Figure 18. Diode recovery time waveform**



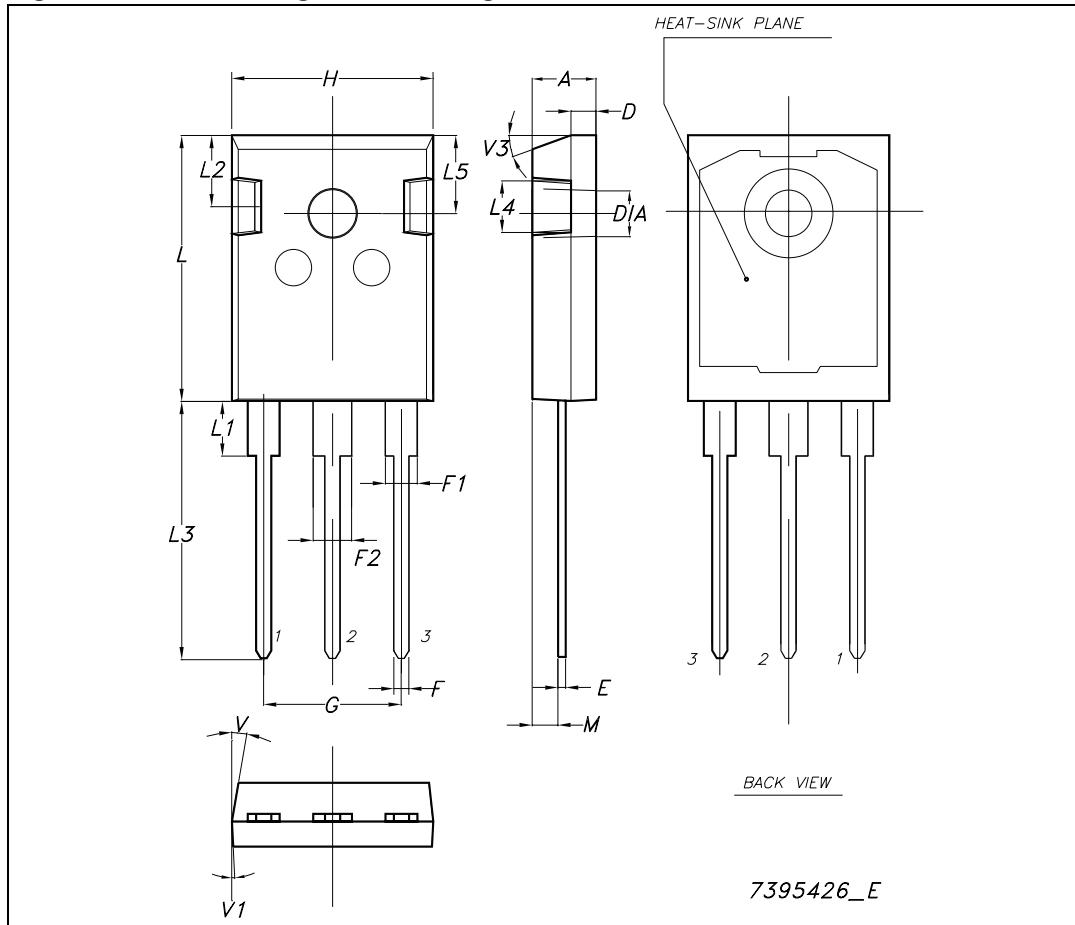
## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

**Table 9. TO-247 long leads mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	4.90		5.15
D	1.85		2.10
E	0.55		0.67
F	1.07		1.32
F1	1.90		2.38
F2	2.87		3.38
G	10.90 BSC		
H	15.77		16.02
L	20.82		21.07
L1	4.16		4.47
L2	5.49		5.74
L3	20.05		20.30
L4	3.68		3.93
L5	6.04		6.29
M	2.27		2.52
V		10°	
V1		3°	
V3		20°	
Dia.	3.55		3.66

Figure 19. TO-247 long leads drawing



## 5 Revision history

**Table 10. Document revision history**

Date	Revision	Changes
20-Jul-2011	1	Initial release.

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